Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/078,074	CHUNG, SEUK HWAN
Examiner	Art Unit
Phylesha L. Dabnev	2646

SEARCHED					
Class	Subclass	Date	Examiner		
381	99,182	11/11/2004	PLD		
	372,396				
	400-401				
	406				
340	388.1				
	388.2				
	407.1				
455	90				
	567				
381	404	2/10/2006			

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
Above	2/10/2006	PLD		
	Subclass	Subclass Date  Above 2/10/2006		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
381/EAST search 340/ EAST search 455/EAST search	11/11/2004	PLD		
381/Update	2/10/2006	PLD		